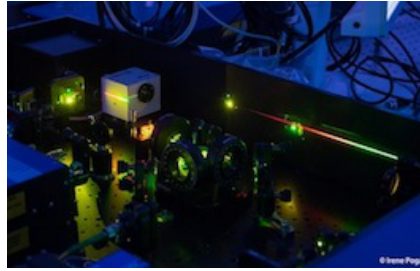


Kick-off meeting of COST action on "Trapped Ions: Progress in Classical and Quantum Applications"



Contribution ID: 14

Type: **not specified**

Preliminary characterization of a surface-electrode ion trap for frequency metrology

Wednesday, 6 March 2019 15:45 (15 minutes)

Presenter: LACROUTE , Clement (FEMTO-ST)